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"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "Embedded - Microcontrollers"

Details	
Product Status	Active
Core Processor	ARM® Cortex®-M3
Core Size	32-Bit Single-Core
Speed	150MHz
Connectivity	CANbus, EBI/EMI, I²C, Microwire, SPI, SSI, SSP, UART/USART
Peripherals	Brown-out Detect/Reset, DMA, I²S, Motor Control PWM, POR, PWM, WDT
Number of I/O	64
Program Memory Size	-
Program Memory Type	ROMless
EEPROM Size	-
RAM Size	136K x 8
Voltage - Supply (Vcc/Vdd)	2V ~ 3.6V
Data Converters	A/D 12x10b; D/A 1x10b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C
Mounting Type	Surface Mount
Package / Case	100-TFBGA
Supplier Device Package	100-TFBGA (9x9)
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/lpc1810fet100-551

4. Ordering information

Table 1. Ordering information

Type number	Package		
	Name	Description	Version
LPC1850FET256	LBGA256	Plastic low profile ball grid array package; 256 balls; body 17 × 17 × 1 mm	SOT740-2
LPC1850FET180	TFBGA180	Thin fine-pitch ball grid array package; 180 balls	SOT570-3
LPC1830FET256	LBGA256	Plastic low profile ball grid array package; 256 balls; body 17 × 17 × 1 mm	SOT740-2
LPC1830FET180	TFBGA180	Thin fine-pitch ball grid array package; 180 balls	SOT570-3
LPC1830FET100	TFBGA100	Plastic thin fine-pitch ball grid array package; 100 balls; body 9 × 9 × 0.7 mm	SOT926-1
LPC1830FBD144	LQFP144	Plastic low profile quad flat package; 144 leads; body 20 × 20 × 1.4 mm	SOT486-1
LPC1820FET100	TFBGA100	Plastic thin fine-pitch ball grid array package; 100 balls; body 9 × 9 × 0.7 mm	SOT926-1
LPC1820FBD144	LQFP144	Plastic low profile quad flat package; 144 leads; body 20 × 20 × 1.4 mm	SOT486-1
LPC1810FET100	TFBGA100	Plastic thin fine-pitch ball grid array package; 100 balls; body 9 × 9 × 0.7 mm	SOT926-1
LPC1810FBD144	LQFP144	Plastic low profile quad flat package; 144 leads; body 20 × 20 × 1.4 mm	SOT486-1

4.1 Ordering options

Table 2. Ordering options

Type number	Total SRAM	LCD	Ethernet	USB0 (Host, Device, OTG)	USB1 (Host, Device)/ ULPI interface	ADC channels	Motor control PWM	QEI	GPIO	Package
LPC1850FET256	200 kB	yes	yes	yes	yes/yes	8	yes	yes	164	LBGA256
LPC1850FET180	200 kB	yes	yes	yes	yes/yes	8	yes	yes	118	TFBGA180
LPC1830FET256	200 kB	no	yes	yes	yes/yes	8	yes	yes	164	LBGA256
LPC1830FET180	200 kB	no	yes	yes	yes/yes	8	yes	yes	118	TFBGA180
LPC1830FET100	200 kB	no	yes	yes	yes/no	4	no	no	49	TFBGA100
LPC1830FBD144	200 kB	no	yes	yes	yes/no	8	yes	no	83	LQFP144
LPC1820FET100	168 kB	no	no	yes	no	4	no	no	49	TFBGA100
LPC1820FBD144	168 kB	no	no	yes	no	8	yes	no	83	LQFP144
LPC1810FET100	136 kB	no	no	no	no	4	no	no	49	TFBGA100
LPC1810FBD144	136 kB	no	no	no	no	8	yes	no	83	LQFP144

Table 3. Pin description *…continued*

LCD, Ethernet, USB0, and USB1 functions are not available on all parts. See Table 2.

Symbol	LBGA256	TFBGA180	TFBGA100	LQFP144		Reset state [1]	Type	Description
P1_12	R9	P7	K7	56	[2]	N; PU	I/O	**GPIO1[5] —** General purpose digital input/output pin.
							I	**U1_DCD —** Data Carrier Detect input for UART1.
							-	**R —** Function reserved.
							I/O	**EMC_D5 —** External memory data line 5.
							I	**T0_CAP1 —** Capture input 1 of timer 0.
							-	**R —** Function reserved.
							-	**R —** Function reserved.
							I/O	**SD_DAT3 —** SD/MMC data bus line 3.
P1_13	R10	L8	H8	60	[2]	N; PU	I/O	**GPIO1[6] —** General purpose digital input/output pin.
							O	**U1_TXD —** Transmitter output for UART1.
							-	**R —** Function reserved.
							I/O	**EMC_D6 —** External memory data line 6.
							I	**T0_CAP0 —** Capture input 0 of timer 0.
							-	**R —** Function reserved.
							-	**R —** Function reserved.
							I	**SD_CD —** SD/MMC card detect input.
P1_14	R11	K7	J8	61	[2]	N; PU	I/O	**GPIO1[7] —** General purpose digital input/output pin.
							I	**U1_RXD —** Receiver input for UART1.
							-	**R —** Function reserved.
							I/O	**EMC_D7 —** External memory data line 7.
							O	**T0_MAT2 —** Match output 2 of timer 0.
							-	**R —** Function reserved.
							-	**R —** Function reserved.
							-	**R —** Function reserved.
P1_15	T12	P11	K8	62	[2]	N; PU	I/O	**GPIO0[2] —** General purpose digital input/output pin.
							O	**U2_TXD —** Transmitter output for USART2.
							-	**R —** Function reserved.
							I	**ENET_RXD0 —** Ethernet receive data 0 (RMII/MII interface).
							O	**T0_MAT1 —** Match output 1 of timer 0.
							-	**R —** Function reserved.
							-	**R —** Function reserved.
							-	**R —** Function reserved.

Table 3. Pin description *…continued*

LCD, Ethernet, USB0, and USB1 functions are not available on all parts. See Table 2.

Symbol	LBGA256	TFBGA180	TFBGA100	LQFP144		Reset state [1]	Type	Description
P1_20	M10	J10	K10	70	[2]	N; PU	I/O	**GPIO0[15] —** General purpose digital input/output pin.
							I/O	**SSP1_SSEL —** Slave Select for SSP1.
							-	**R —** Function reserved.
							O	**ENET_TXD1 —** Ethernet transmit data 1 (RMII/MII interface).
							I	**T0_CAP2 —** Capture input 2 of timer 0.
							-	**R —** Function reserved.
							-	**R —** Function reserved.
							-	**R —** Function reserved.
P2_0	T16	N14	G10	75	[2]	N; PU	-	**R —** Function reserved.
							O	**U0_TXD —** Transmitter output for USART0.
							I/O	**EMC_A13 —** External memory address line 13.
							O	**USB0_PPWR —** VBUS drive signal (towards external charge pump or power management unit); indicates that VBUS must be driven (active high). Add a pull-down resistor to disable the power switch at reset. This signal has opposite polarity compared to the USB_PPWR used on other NXP LPC parts.
							I/O	**GPIO5[0] —** General purpose digital input/output pin.
							-	**R —** Function reserved.
							I	**T3_CAP0 —** Capture input 0 of timer 3.
							O	**ENET_MDC —** Ethernet MIIM clock.
P2_1	N15	M13	G7	81	[2]	N; PU	-	**R —** Function reserved.
							I	**U0_RXD —** Receiver input for USART0.
							I/O	**EMC_A12 —** External memory address line 12.
							I	**USB0_PWR_FAULT —** Port power fault signal indicating overcurrent condition; this signal monitors over-current on the USB bus (external circuitry required to detect over-current condition).
							I/O	**GPIO5[1] —** General purpose digital input/output pin.
							-	**R —** Function reserved.
							I	**T3_CAP1 —** Capture input 1 of timer 3.
							-	**R —** Function reserved.

Table 3. Pin description *…continued*

LCD, Ethernet, USB0, and USB1 functions are not available on all parts. See Table 2.

Symbol	LBGA256	TFBGA180	TFBGA100	LQFP144		Reset state [1]	Type	Description
PD_16	R14	P12	-	-	[2]	N; PU	-	**R —** Function reserved.
							-	**R —** Function reserved.
							I/O	**EMC_A16 —** External memory address line 16.
							-	**R —** Function reserved.
							I/O	**GPIO6[30] —** General purpose digital input/output pin.
							O	**SD_VOLT2 —** SD/MMC bus voltage select output 2.
							O	**CTOUT_12 —** SCTimer/PWM output 12. Match output 3 of timer 3.
							-	**R —** Function reserved.
PE_0	P14	N12	-	-	[2]	N; PU	-	**R —** Function reserved.
							-	**R —** Function reserved.
							-	**R —** Function reserved.
							I/O	**EMC_A18 —** External memory address line 18.
							I/O	**GPIO7[0] —** General purpose digital input/output pin.
							O	**CAN1_TD —** CAN1 transmitter output.
							-	**R —** Function reserved.
							-	**R —** Function reserved.
PE_1	N14	M12	-	-	[2]	N; PU	-	**R —** Function reserved.
							-	**R —** Function reserved.
							-	**R —** Function reserved.
							I/O	**EMC_A19 —** External memory address line 19.
							I/O	**GPIO7[1] —** General purpose digital input/output pin.
							I	**CAN1_RD —** CAN1 receiver input.
							-	**R —** Function reserved.
							-	**R —** Function reserved.
PE_2	M14	L12	-	-	[2]	N; PU	I	**ADCTRIG0 —** ADC trigger input 0.
							I	**CAN0_RD —** CAN receiver input.
							-	**R —** Function reserved.
							I/O	**EMC_A20 —** External memory address line 20.
							I/O	**GPIO7[2] —** General purpose digital input/output pin.
							-	**R —** Function reserved.
							-	**R —** Function reserved.
							-	**R —** Function reserved.

Table 3. Pin description *…continued*

LCD, Ethernet, USB0, and USB1 functions are not available on all parts. See Table 2.

Symbol	LBGA256	TFBGA180	TFBGA100	LQFP144		Reset state [1]	Type	Description
PE_7	F15	-	-	-	[2]	N; PU	-	**R —** Function reserved.
							O	**CTOUT_5 —** SCTimer/PWM output 5. Match output 3 of timer 3.
							I	**U1_CTS —** Clear to Send input for UART1.
							I/O	**EMC_D26 —** External memory data line 26.
							I/O	**GPIO7[7] —** General purpose digital input/output pin.
							-	**R —** Function reserved.
							-	**R —** Function reserved.
							-	**R —** Function reserved.
PE_8	F14	-	-	-	[2]	N; PU	-	**R —** Function reserved.
							O	**CTOUT_4 —** SCTimer/PWM output 4. Match output 3 of timer 3.
							I	**U1_DSR —** Data Set Ready input for UART1.
							I/O	**EMC_D27 —** External memory data line 27.
							I/O	**GPIO7[8] —** General purpose digital input/output pin.
							-	**R —** Function reserved.
							-	**R —** Function reserved.
							-	**R —** Function reserved.
PE_9	E16	-	-	-	[2]	N; PU	-	**R —** Function reserved.
							I	**CTIN_4 —** SCTimer/PWM input 4. Capture input 2 of timer 1.
							I	**U1_DCD —** Data Carrier Detect input for UART1.
							I/O	**EMC_D28 —** External memory data line 28.
							I/O	**GPIO7[9] —** General purpose digital input/output pin.
							-	**R —** Function reserved.
							-	**R —** Function reserved.
							-	**R —** Function reserved.
PE_10	E14	-	-	-	[2]	N; PU	-	**R —** Function reserved.
							I	**CTIN_3 —** SCTimer/PWM input 3. Capture input 1 of timer 1.
							O	**U1_DTR —** Data Terminal Ready output for UART1. Can also be configured to be an RS-485/EIA-485 output enable signal for UART1.
							I/O	**EMC_D29 —** External memory data line 29.
							I/O	**GPIO7[10] —** General purpose digital input/output pin.
							-	**R —** Function reserved.
							-	**R —** Function reserved.
							-	**R —** Function reserved.

Table 3. Pin description *…continued*

LCD, Ethernet, USB0, and USB1 functions are not available on all parts. See Table 2.

Symbol	LBGA256	TFBGA180	TFBGA100	LQFP144		Reset state [1]	Type	Description
Power and ground pins								
USB0_VDDA3V3_DRIVER	F3	E3	D1	16		-	-	Separate analog 3.3 V power supply for driver.
USB0_VDDA3V3	G3	F3	D2	17		-	-	USB 3.3 V separate power supply voltage.
USB0_VSSA_TERM	H3	G3	D3	19		-	-	Dedicated analog ground for clean reference for termination resistors.
USB0_VSSA_REF	G1	F1	F2	23		-	-	Dedicated clean analog ground for generation of reference currents and voltages.
VDDA	B4	A6	B2	137		-	-	Analog power supply and ADC reference voltage.
VBAT	B10	B9	C5	127		-	-	RTC power supply: 3.3 V on this pin supplies power to the RTC.
VDDREG	F10, F9, L8, L7	D8, E8	E4, E5, F4	94, 131, 59, 25			-	Main regulator power supply. Tie the VDDREG and VDDIO pins to a common power supply to ensure the same ramp-up time for both supply voltages.
VPP	E8	-	-	-	[12]	-	-	OTP programming voltage.
VDDIO	D7, E12, F7, F8, G10, H10, J6, J7, K7, L9, L10, N7, N13	H5, H10, K8, G10	F10, K5	5, 36, 41, 71, 77, 107, 111, 141	[12]	-	-	I/O power supply. Tie the VDDREG and VDDIO pins to a common power supply to ensure the same ramp-up time for both supply voltages.
VSS	G9, H7, J10, J11, K8	F10, D7, E6, E7, E9, K6, K9	C8, D4, D5, G8, J3, J6	-	[13]	-	-	Ground.

- Clock selection
- Inputs
- Events
- Outputs
- Interrupts

7.13.1.1 Features

- Two 16-bit counters or one 32-bit counter.
- Counters clocked by bus clock or selected input.
- Counters can be configured as up counters or up-down counters.
- State variable allows sequencing across multiple counter cycles.
- Event combines input or output condition and/or counter match in a specified state.
- Events control outputs and interrupts.
- Selected events can limit, halt, start, or stop a counter.
- Supports:
  - up to 8 inputs
  - up to 16 outputs
  - 16 match/capture registers
  - 16 events
  - 32 states

7.13.2 General-purpose DMA

The DMA controller allows peripheral-to memory, memory-to-peripheral, peripheral-to-peripheral, and memory-to-memory transactions. Each DMA stream provides unidirectional serial DMA transfers for a single source and destination. For example, a bidirectional port requires one stream for transmit and one for receives. The source and destination areas can each be either a memory region or a peripheral for master 1, but only memory for master 0.

7.13.2.1 Features

- Eight DMA channels. Each channel can support a unidirectional transfer.
- 16 DMA request lines.
- Single DMA and burst DMA request signals. Each peripheral connected to the DMA Controller can assert either a burst DMA request or a single DMA request. The DMA burst size is set by programming the DMA Controller.
- Memory-to-memory, memory-to-peripheral, peripheral-to-memory, and peripheral-to-peripheral transfers are supported.
- Scatter or gather DMA is supported through the use of linked lists. This means that the source and destination areas do not have to occupy contiguous areas of memory.
- Hardware DMA channel priority.
- AHB slave DMA programming interface. The DMA Controller is programmed by writing to the DMA control registers over the AHB slave interface.

7.18.3 Clock Generation Unit (CGU)

The Clock Generator Unit (CGU) generates several base clocks. The base clocks can be unrelated in frequency and phase and can have different clock sources within the CGU. One CGU base clock is routed to the CLKOUT pins. The base clock that generates the CPU clock is referred to as CCLK.

Multiple branch clocks are derived from each base clock. The branch clocks offer flexible control for power-management purposes. All branch clocks are outputs of one of two Clock Control Units (CCUs) and can be controlled independently. Branch clocks derived from the same base clock are synchronous in frequency and phase.

7.18.4 Internal RC oscillator (IRC)

The IRC is used as the clock source for the WWDT and/or as the clock that drives the PLLs and the CPU. The nominal IRC frequency is 12 MHz. The IRC is trimmed to 1.5 % accuracy over the entire voltage and temperature range.

Upon power-up or any chip reset, the LPC1850/30/20/10 use the IRC as the clock source. The boot loader then configures the PLL1 to provide a 96 MHz clock for the core and the PLL0USB or PLL0AUDIO as needed if an external boot source is selected.

7.18.5 PLL0USB (for USB0)

PLL0 is a dedicated PLL for the USB0 High-speed controller.

PLL0 accepts an input clock frequency from an external oscillator in the range of 14 kHz to 25 MHz. The input frequency is multiplied up to a high frequency with a Current Controlled Oscillator (CCO). The CCO operates in the range of 4.3 MHz to 550 MHz.

7.18.6 PLL0AUDIO (for audio)

The audio PLL PLL0AUDIO is a general-purpose PLL with a small step size. This PLL accepts an input clock frequency derived from an external oscillator or internal IRC. The input frequency is multiplied up to a high frequency with a Current Controlled Oscillator (CCO). A sigma-delta converter modulates the PLL divider ratios to obtain the desired output frequency. The output frequency can be set as a multiple of the sampling frequency f_s to $32 \times f_s$, $64 \times f_s$, $128 \times f_s$, $256 \times f_s$, $384 \times f_s$, $512 \times f_s$ and the sampling frequency f_s can range from 16 kHz to 192 kHz (16, 22.05, 32, 44.1, 48, 96,192) kHz. Many other frequencies are possible as well using the integrated fractional divider.

7.18.7 System PLL1

The PLL1 accepts an input clock frequency from an external oscillator in the range of 1 MHz to 25 MHz. The input frequency is multiplied up to a high frequency with a Current Controlled Oscillator (CCO). The multiplier can be an integer value from 1 to 32. The CCO operates in the range of 156 MHz to 320 MHz. This range is possible through an additional divider in the loop to keep the CCO within its frequency range while the PLL is providing the desired output frequency. The output divider can be set to divide by 2, 4, 8, or 16 to produce the output clock. Since the minimum output divider value is 2, it is insured that the PLL output has a 50 % duty cycle. The PLL is turned off and bypassed following a chip reset. After reset, software can enable the PLL. The program must configure and activate the PLL, wait for the PLL to lock, and then connect to the PLL as a clock source. The PLL settling time is 100 μs.

[5] PLL1 disabled; IRC running; CCLK = 12 MHz.

[6] V_{BAT} = 3.6 V.

[7] $V_{DD(IO)} = V_{DDA}$ = 3.6 V; over entire frequency range CCLK = 12 MHz to 180 MHz.

[8] $V_{DD(REG)(3V3)}$ = 3.3 V; $V_{DD(IO)}$ = 3.3 V. Input leakage increases when $V_{DD(IO)}$ is floating or grounded. It is recommended to keep $V_{DD(REG)(3V3)}$ and $V_{DD(IO)}$ powered in deep power-down mode.

[9] On pin VBAT; T_{amb} = 25 °C.

[10] V_{ps} corresponds to the output of the power switch (see Figure 9) which is determined by the greater of V_{BAT} and $V_{DD(Reg)(3V3)}$.

[11] $V_{DDA(3V3)}$ = 3.3 V; T_{amb} = 25 °C.

[12] Allowed as long as the current limit does not exceed the maximum current allowed by the device.

[13] To V_{SS}.

[14] The values specified are simulated and absolute values.

[15] The weak pull-up resistor is connected to the $V_{DD(IO)}$ rail and pulls up the I/O pin to the $V_{DD(IO)}$ level.

[16] The input cell disables the weak pull-up resistor when the applied input voltage exceeds $V_{DD(IO)}$.

[17] The parameter value specified is a simulated value excluding bond capacitance.

[18] For USB operation 3.0 V $\leq V_{DD((IO)} \leq$ 3.6 V. Guaranteed by design.

[19] $V_{DD(IO)}$ present.

[20] Includes external resistors of 33 $\Omega \pm 1$ % on D+ and D−.

11. Dynamic characteristics

11.1 Wake-up times

Table 13. Dynamic characteristic: Wake-up from Deep-sleep, Power-down, and Deep power-down modes

T_{amb} = −40 °C to +85 °C

Symbol	Parameter	Conditions		Min	Typ[1]	Max	Unit
t_{wake}	wake-up time	from Sleep mode	[2]	$3 \times T_{cy(clk)}$	$5 \times T_{cy(clk)}$	-	ns
		from Deep-sleep and Power-down mode		12	51	-	µs
		from Deep power-down mode		-	250	-	µs
		after reset		-	250	-	µs

[1] Typical ratings are not guaranteed. The values listed are at room temperature (25 °C), nominal supply voltages.

[2] $T_{cy(clk)}$ = 1/CCLK with CCLK = CPU clock frequency.

11.2 External clock for oscillator in slave mode

Remark: The input voltage on the XTAL1/2 pins must be ≤ 1.2 V (see Table 10). For connecting the oscillator to the XTAL pins, also see Section 13.2 and Section 13.4.

Table 14. Dynamic characteristic: external clock

T_{amb} = −40 °C to +85 °C; $V_{DD(IO)}$ over specified ranges.[1]

Symbol	Parameter	Min	Max	Unit
f_{osc}	oscillator frequency	1	25	MHz
$T_{cy(clk)}$	clock cycle time	40	1000	ns
t_{CHCX}	clock HIGH time	$T_{cy(clk)} \times 0.4$	$T_{cy(clk)} \times 0.6$	ns
t_{CLCX}	clock LOW time	$T_{cy(clk)} \times 0.4$	$T_{cy(clk)} \times 0.6$	ns

[1] Parameters are valid over operating temperature range unless otherwise specified.

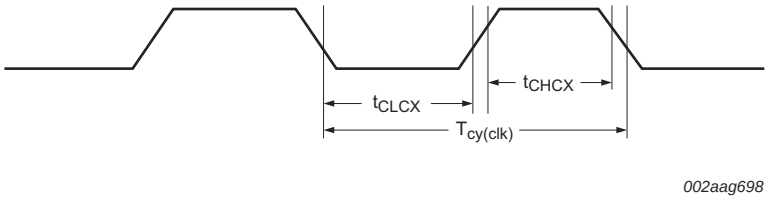


Fig 25. External clock timing (with an amplitude of at least $V_{i(RMS)}$ = 200 mV)

Table 23. Dynamic characteristics: SSP pins in SPI mode

T_{amb} = −40 °C to +85 °C; 2.2 V ≤ $V_{DD(REG)(3V3)}$ ≤ 3.6 V; 2.7 V ≤ $V_{DD(IO)}$ ≤ 3.6 V; C_L = 20 pF. Sampled at 10 % and 90 % of the signal level; EHS = 1 for all pins. Simulated values.

Symbol	Parameter	Conditions		Min	Typ	Max	Unit
t_{lag}	lag time	continuous transfer mode SPI mode; CPOL = 0; CPHA = 0		$0.5T_{cy(clk)}$ + 0.2	-	-	ns
		SPI mode; CPOL = 0; CPHA = 1		$T_{cy(clk)}$ + 0.2	-	-	ns
		SPI mode; CPOL = 1; CPHA = 0		0.5 × $T_{cy(clk)}$ + 0.2	-	-	ns
		SPI mode; CPOL = 1; CPHA = 1		$T_{cy(clk)}$ + 0.2	-	-	ns
		synchronous serial frame mode		$T_{cy(clk)}$ + 0.2	-	-	ns
		microwire frame format		0.5 × $T_{cy(clk)}$	-	-	ns
t_d	delay time	continuous transfer mode SPI mode; CPOL = 0; CPHA = 0		-	0.5 × $T_{cy(clk)}$	-	ns
		SPI mode; CPOL = 0; CPHA = 1		-	n/a	-	ns
		SPI mode; CPOL = 1; CPHA = 0		-	0.5 × $T_{cy(clk)}$	-	ns
		SPI mode; CPOL = 1; CPHA = 1		-	n/a	-	ns
		synchronous serial frame mode		-	$T_{cy(clk)}$	-	ns
		microwire frame format		-	n/a	-	ns

[1] $T_{cy(clk)}$ = (SSPCLKDIV × (1 + SCR) × CPSDVSR) / f_{main}. The clock cycle time derived from the SPI bit rate $T_{cy(clk)}$ is a function of the main clock frequency f_{main}, the SSP peripheral clock divider (SSPCLKDIV), the SSP SCR parameter (specified in the SSP0CR0 register), and the SSP CPSDVSR parameter (specified in the SSP clock prescale register).

[2] $T_{cy(clk)} \geq 12 \times T_{cy(PCLK)}$.

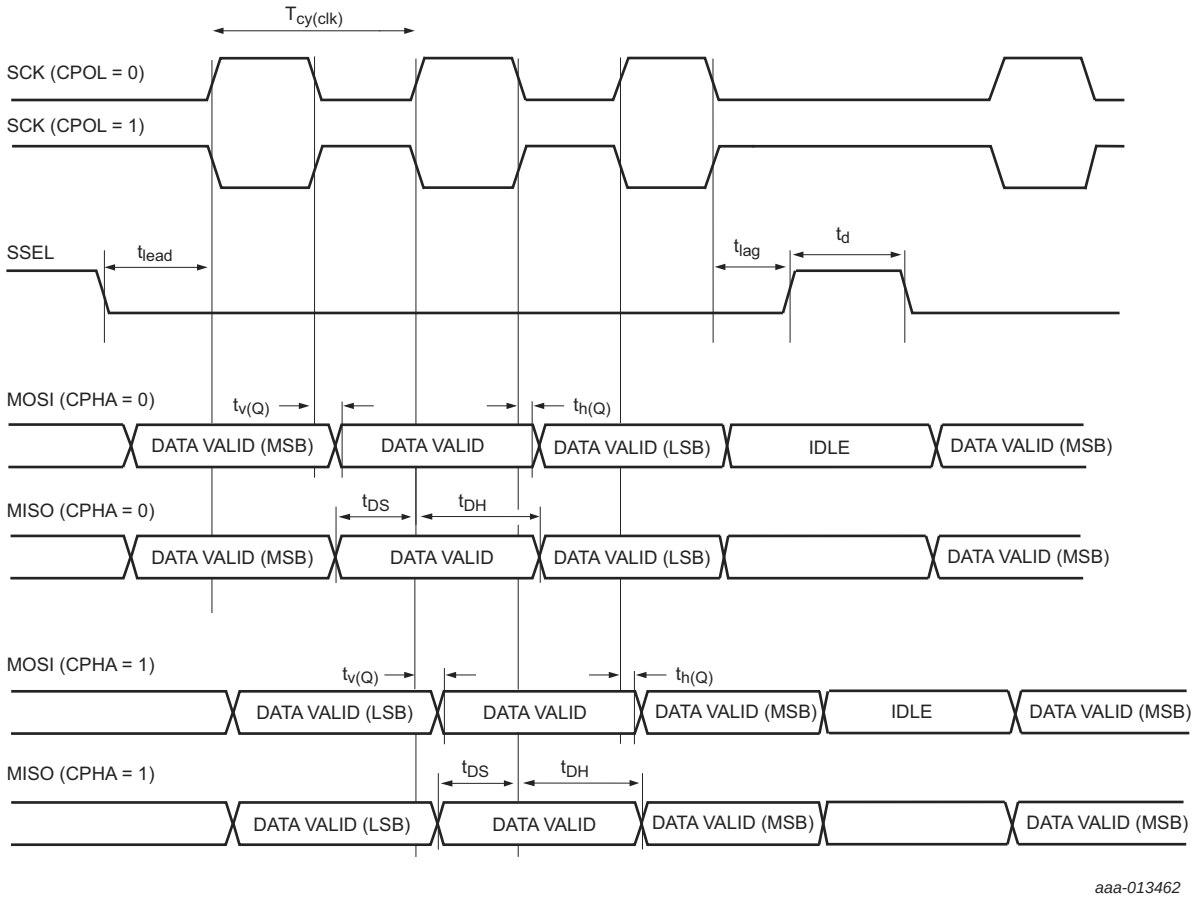


Fig 30. SSP master timing in SPI mode

Table 28. Static characteristics: USB0 PHY pins[1]

Symbol	Parameter	Conditions		Min	Typ	Max	Unit
High-speed mode							
P_{cons}	power consumption		[2]	-	68	-	mW
$I_{DDA(3V3)}$	analog supply current (3.3 V)	on pin USB0_VDDA3V3_DRIVER; total supply current	[3]	-	18	-	mA
		during transmit		-	31	-	mA
		during receive		-	14	-	mA
		with driver tri-stated		-	14	-	mA
I_{DDD}	digital supply current			-	7	-	mA
Full-speed/low-speed mode							
P_{cons}	power consumption		[2]	-	15	-	mW
$I_{DDA(3V3)}$	analog supply current (3.3 V)	on pin USB0_VDDA3V3_DRIVER; total supply current		-	3.5	-	mA
		during transmit		-	5	-	mA
		during receive		-	3	-	mA
		with driver tri-stated		-	3	-	mA
I_{DDD}	digital supply current			-	3	-	mA
Suspend mode							
$I_{DDA(3V3)}$	analog supply current (3.3 V)			-	24	-	μA
		with driver tri-stated		-	24	-	μA
		with OTG functionality enabled		-	3	-	mA
I_{DDD}	digital supply current			-	30	-	μA
VBUS detector outputs							
V_{th}	threshold voltage	for VBUS valid		4.4	-	-	V
		for session end		0.2	-	0.8	V
		for A valid		0.8	-	2	V
		for B valid		2	-	4	V
V_{hys}	hysteresis voltage	for session end		-	150	10	mV
		A valid		-	200	10	mV
		B valid		-	200	10	mV

[1] Characterized but not implemented as production test.

[2] Total average power consumption.

[3] The driver is active only 20 % of the time.

11.14 Ethernet

Remark: The timing characteristics of the ENET_MDC and ENET_MDIO signals comply with the *IEEE standard 802.3*.

Table 29. Dynamic characteristics: Ethernet

T_{amb} = −40 °C to 85 °C; 2.2 V ≤ $V_{DD(REG)(3V3)}$ ≤ 3.6 V; 2.7 V ≤ $V_{DD(IO)}$ ≤ 3.6 V. Values guaranteed by design.

Symbol	Parameter	Conditions		Min	Max	Unit
RMII mode						
f_{clk}	clock frequency	for ENET_RX_CLK	[1]	-	50	MHz
δ_{clk}	clock duty cycle		[1]	50	50	%
t_{su}	set-up time	for ENET_TXDn, ENET_TX_EN, ENET_RXDn, ENET_RX_ER, ENET_RX_DV	[1][2]	4	-	ns
t_h	hold time	for ENET_TXDn, ENET_TX_EN, ENET_RXDn, ENET_RX_ER, ENET_RX_DV	[1][2]	2	-	ns
MII mode						
f_{clk}	clock frequency	for ENET_TX_CLK	[1]	-	25	MHz
δ_{clk}	clock duty cycle		[1]	50	50	%
t_{su}	set-up time	for ENET_TXDn, ENET_TX_EN, ENET_TX_ER	[1][2]	4	-	ns
t_h	hold time	for ENET_TXDn, ENET_TX_EN, ENET_TX_ER	[1][2]	2	-	ns
f_{clk}	clock frequency	for ENET_RX_CLK	[1]	-	25	MHz
δ_{clk}	clock duty cycle		[1]	50	50	%
t_{su}	set-up time	for ENET_RXDn, ENET_RX_ER, ENET_RX_DV	[1][2]	4	-	ns
t_h	hold time	for ENET_RXDn, ENET_RX_ER, ENET_RX_DV	[1][2]	2	-	ns

[1] Output drivers can drive a load ≥ 25 pF accommodating over 12 inch of PCB trace and the input capacitance of the receiving device.

[2] Timing values are given from the point at which the clock signal waveform crosses 1.4 V to the valid input or output level.

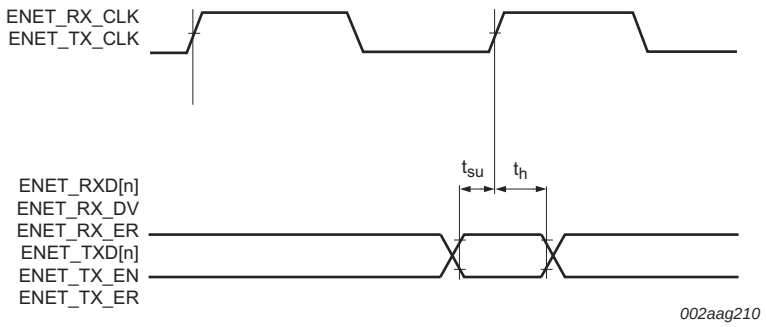
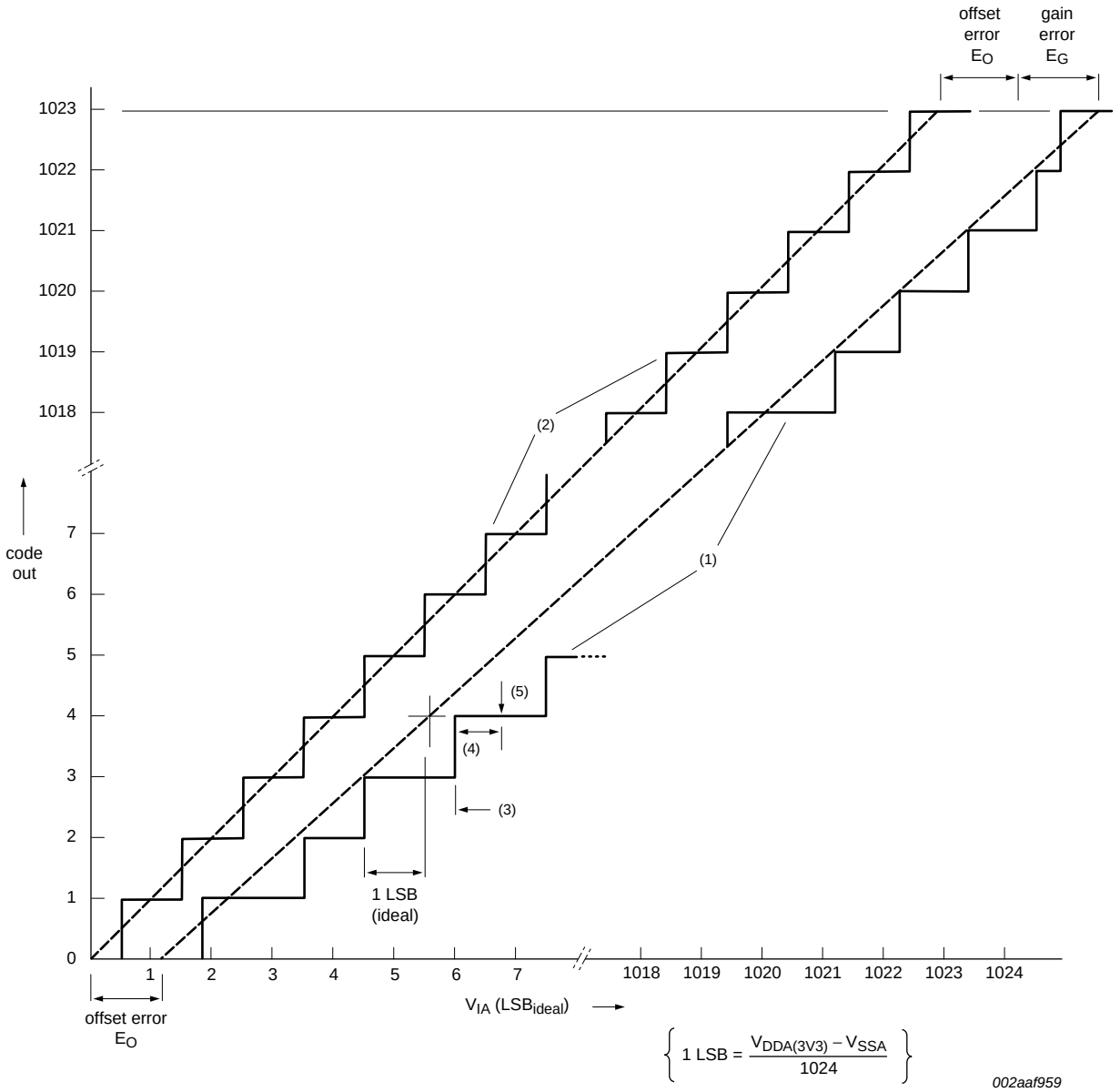


Fig 36. Ethernet timing



(1) Example of an actual transfer curve.

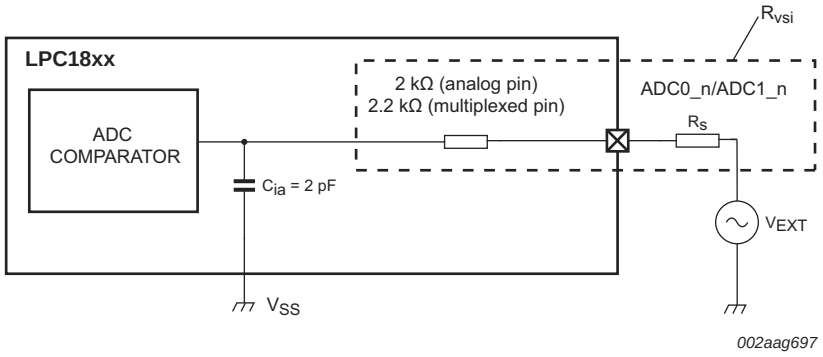
(2) The ideal transfer curve.

(3) Differential linearity error (E_D).

(4) Integral non-linearity ($E_{L(adj)}$).

(5) Center of a step of the actual transfer curve.

Fig 39. 10-bit ADC characteristics



$Rs < 1/((7 \times f_{clk(ADC)}) \times C_{ia}) - 2\ k\Omega$

Fig 40. ADC interface to pins

Table 34. DAC characteristics

$V_{DDA(3V3)}$ over specified ranges; T_{amb} = −40 °C to +85 °C; unless otherwise specified

Symbol	Parameter	Conditions		Min	Typ	Max	Unit
E_D	differential linearity error	2.7 V ≤ $V_{DDA(3V3)}$ ≤ 3.6 V	[1]	-	±0.8	-	LSB
		2.2 V ≤ $V_{DDA(3V3)}$ < 2.7 V		-	±1.0	-	LSB
$E_{L(adj)}$	integral non-linearity	code = 0 to 975 2.7 V ≤ $V_{DDA(3V3)}$ ≤ 3.6 V	[1]	-	±1.0	-	LSB
		2.2 V ≤ $V_{DDA(3V3)}$ < 2.7 V		-	±1.5	-	LSB
E_O	offset error	2.7 V ≤ $V_{DDA(3V3)}$ ≤ 3.6 V	[1]	-	±0.8	-	LSB
		2.2 V ≤ $V_{DDA(3V3)}$ < 2.7 V		-	±1.0	-	LSB
E_G	gain error	2.7 V ≤ $V_{DDA(3V3)}$ ≤ 3.6 V	[1]	-	±0.3	-	%
		2.2 V ≤ $V_{DDA(3V3)}$ < 2.7 V		-	±1.0	-	%
C_L	load capacitance			-	-	200	pF
R_L	load resistance			1	-	-	kΩ
t_s	settling time		[1]		0.4		μσ

[1] In the DAC CR register, bit BIAS = 0 (see the *LPC18xx user manual*).

[2] Settling time is calculated within 1/2 LSB of the final value.

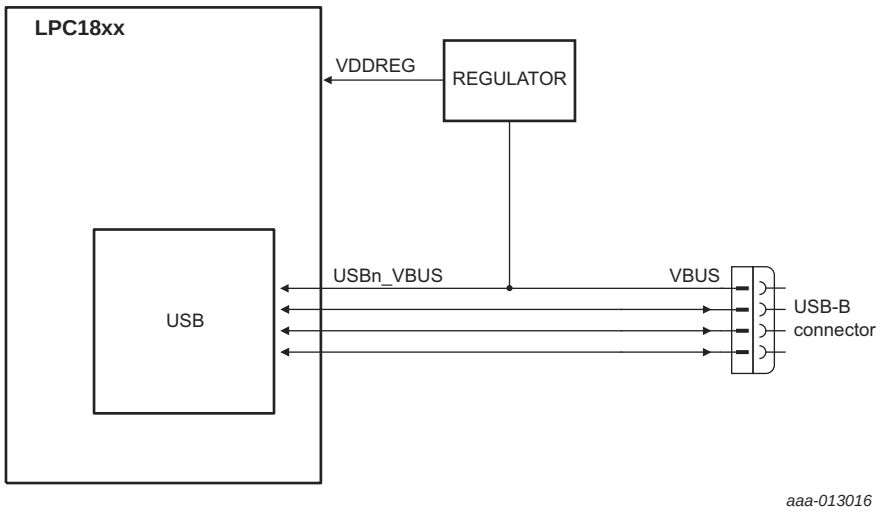


Fig 47. USB interface on a bus-powered device

Remark: If the VBUS function of the USB1 interface is not connected, configure the pin function for GPIO using the function control bits in the SYSCON block.

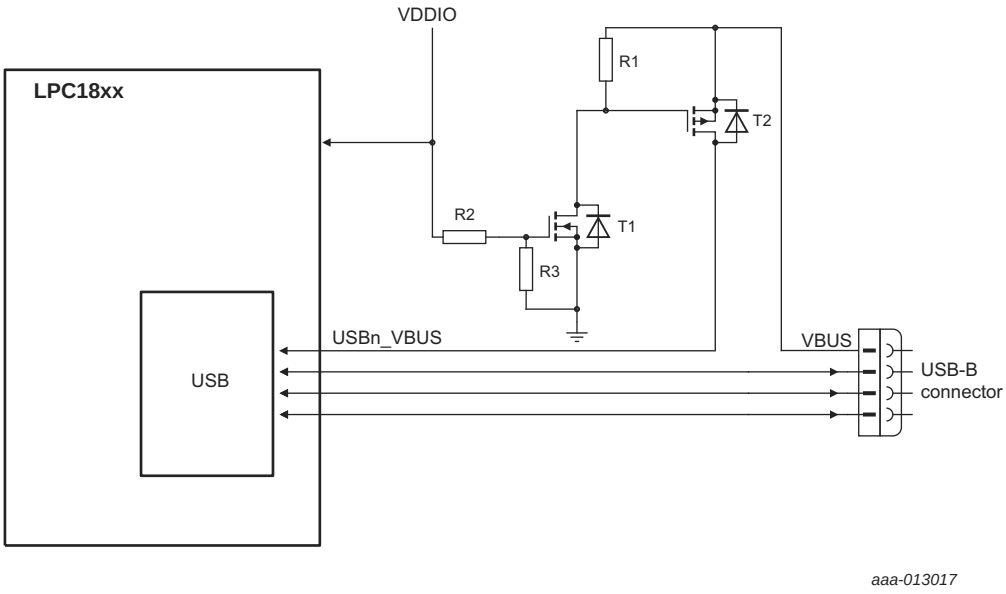
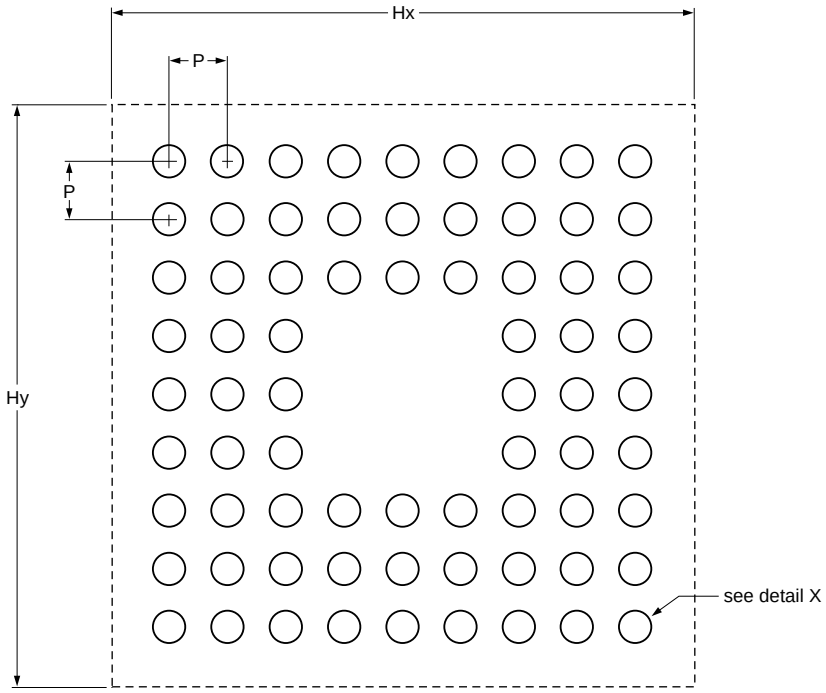


Fig 48. USB interface if the USB operates in OTG mode

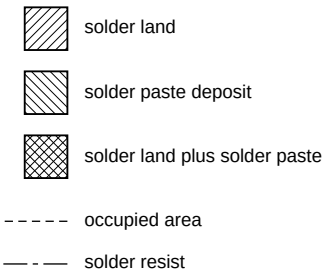
Remark: In OTG mode, it is important to be able to detect the VBUS level and to charge and discharge VBUS. This requires adding active devices that disconnect the link when VDDIO is not present.

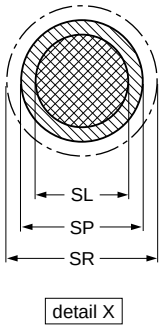
Footprint information for reflow soldering of TFBGA100 package **SOT926-1**



Generic footprint pattern

Refer to the package outline drawing for actual layout





detail X

DIMENSIONS in mm

P	SL	SP	SR	Hx	Hy
0.80	0.330	0.400	0.480	9.400	9.400

sot926-1_fr

Fig 56. Reflow soldering of the TFBGA100 package

Table 40. Abbreviations *...continued*

Acronym	Description
USART	Universal Synchronous Asynchronous Receiver/Transmitter
USB	Universal Serial Bus
UTMI	USB 2.0 Transceiver Macrocell Interface

17. References

[1] LPC18xx User manual UM10430: http://www.nxp.com/documents/user_manual/UM10430.pdf

[2] LPC18X0 Errata sheet: http://www.nxp.com/documents/errata_sheet/ES_LPC18X0.pdf

18. Revision history

Table 41. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
LPC1850_30_20_10 v.6.7	20160314	Product data sheet	-	LPC1850_30_20_10 v.6.6
	• Updated Table 25 “Dynamic characteristics: Dynamic external memory interface”: Read cycle parameters $t_{h(D)}$ min value is 2.2 ns and max value is “-”.			
LPC1850_30_20_10 v.6.6	20151116	Product data sheet	2015110031	LPC1850_30_20_10 v.6.5
Modifications:	**Updated SSP slave and SSP master values in Table 23 “Dynamic characteristics: SSP pins in SPI mode”. Updated footnote 2 to: $T_{cy(clk)} \geq 12 \times T_{cy(PCLK)}$.** • **removed $t_{v(Q)}$, data output valid time in SPI mode, minimum value of 3 ´ (1/PCLK) from SSP slave mode.** • **added units to t_d, delay time, for SSP slave and master mode.** **Added GPCLKIN section and table. See Section 11.6 “GPCLKIN” and Table 18 “Dynamic characteristic: GPCLKIN”.**			
LPC1850_30_20_10 v.6.5	20150430	Product data sheet	-	LPC1850_30_20_10 v.6.4
Modifications:	• For WAKEUP pin description: Changed external pull-up to internal pull-up. See Table 3 “Pin description”. • Table note 2 corrected in Table 10. • Updated USART dynamic characteristics table. See Table 22. • Added SSP slave timing data. See Table 22. • Added USART timing diagram. See Figure 29. • Updated SD/MMC dynamic characteristics table. See Table 30. • Updated SPIFI dynamic characteristics table. See Table 32. • Updated Dynamic characteristics: USB0 and USB1 pins (full-speed). See Table 27. • Updated Table 2: Motor control PWM instead of PWM. • Added a remark to Table 27.			
LPC1850_30_20_10 v.6.4	20140818	Product data sheet	201408013F01	LPC1850_30_20_10 v.6.3